

**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

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In re Patent Application of:  
John Z.Z. Zhong et al.

Application No.: Not Yet Assigned

Customer No.: 30827

Filed: March 15, 2004

Art Unit: N/A

For: HIGH APERTURE LCD WITH  
INSULATING COLOR FILTERS  
OVERLAPPING BUS LINES ON ACTIVE  
SUBSTRATE

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Examiner: Not Yet Assigned

**INFORMATION DISCLOSURE STATEMENT (IDS)**

MS Patent Application  
Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Dear Sir:

Pursuant to 37 CFR 1.56, 1.97 and 1.98, the attention of the Patent and Trademark Office is hereby directed to the references listed on the attached PTO/SB/08. It is respectfully requested that the information be expressly considered during the prosecution of this application, and that the references be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

This Information Disclosure Statement accompanies the continuation application submitted herewith. The listed references have been previously submitted in related case Serial No. 10/068,873 filed February 11, 2002.

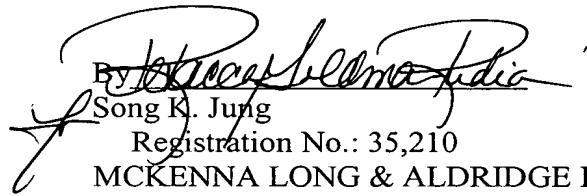
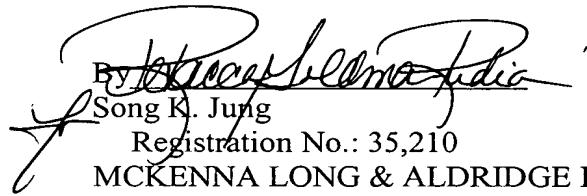
In accordance with 37 CFR 1.97(g), the filing of this Information Disclosure Statement shall not be construed to mean that a search has been made or that no other material information as defined in 37 CFR 1.56(a) exists. In accordance with 37 CFR 1.97(h), the filing of this Information Disclosure statement shall not be construed to be an admission that any

patent, publication or other information referred to therein is "prior art" for this invention unless specifically designated as such.

It is submitted that the Information Disclosure Statement is in compliance with 37 CFR 1.98 and the Examiner is respectfully requested to consider the listed references.

Dated: March 15, 2004

Respectfully submitted,

  
By   
Song K. Jung Reg. No.  
4,786  
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Attorney for Applicant

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Substitute for form 1449A/B/PTO				Complete if Known		
				Application Number	10/068,873-Conf. #2630	
				Filing Date	February 11, 2002	
				First Named Inventor	John Z.Z. Zhong	
				Art Unit	2815	
				Examiner Name	A. R. Wilson	
Sheet	1	of	1	Attorney Docket Number		8733.216.20-US

U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No. <sup>1</sup>	Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number-Kind Code <sup>2</sup> (if known)			
AA					
AB					
AC					
AD					
AE					
AF					
AG					
AH					
AI					
AJ					

FOREIGN PATENT DOCUMENTS					
Examiner Initials*	Cite No. <sup>1</sup>	Foreign Patent Document	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Country Code <sup>3</sup> -Number <sup>4</sup> -Kind Code <sup>5</sup> (if known)			
BA		JP-06-242433	09-02-1994	KAZUHIRO et al.	
BB		JP-04-307520	10-29-1992	TAKASHI	
BC					
BD					
BE					
BF					
BG					
BH					
BI					
BJ					

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NON PATENT LITERATURE DOCUMENTS					
Examiner Initials	Cite No. <sup>1</sup>	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.			T <sup>2</sup>
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CB					
CC					
CD					
CE					

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Substitute for form 1449/PTO				Complete if Known	
				Application Number	10/068,873
				Filing Date	February 11, 2002
				First Named Inventor	John Z.Z. Zhong
				Art Unit	2815
				Examiner Name	Allan R. Wilson
Sheet	1	of	1	Attorney Docket Number	8733.216.20-US

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BA		JP-06242433-A	09-02-1994	Kazuhiko et al.	T <sup>6</sup>
BB		JP-07028093-A	01-31-1995	Masaharu	
BC		JP-06208137-A	07-26-1994	Kiyoshi	
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BL		JP-02308226-A	12-21-1990	Yuji et al.	

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				First Named Inventor	John Z.Z. Zhong
				Art Unit	2815
				Examiner Name	A. Wilson
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		Number-Kind Code <sup>2</sup> (if known)	MM-DD-YYYY		
AA		5,229,644-A1	07-20-1993	Wakai et al.	

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BA		EP-0 490 335-A2	06-17-1992	Kennedy et al.	
BB		EP-0 603 866-A1	06-29-1994	Noda et al.	

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<b>OTHER PRIOR ART – NON PATENT LITERATURE DOCUMENTS</b>					
Examiner Initials	Cite No. <sup>1</sup>	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc), date, page(s), volume-issue number(s), publisher, city and/or country where published.			T <sup>2</sup>
	CA	D. Perettie et al., "Benzocyclobutene as a Planarization Resin for Flat Panel Displays," Proceedings of the Spie, Vol. 1665, 11-13 February 1992, pp. 331-337			
	CB	Abstract of Japanese Patent Publication No. 06242467, dated 09/02/94			
	CC	Abstract of Japanese Patent Publication No. 02196221, dated 08/02/90			
	CD	Abstract of Japanese Patent Publication No. 04163528; dated 06/09/92			
	CE	Abstract of Japanese Patent Publication No. 04291240; dated 10/15/92			
	CF	Abstract of Japanese Patent Publication No. 03242625, dated 10/29/91			
	CG	M.J. Radler et al., "Cyclotene Advanced Electronics Resins for High-Aperture AMLCD,: SID 96 Applications Digest, pp. 33-36			

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Examiner Signature	Date Considered
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**Notice of References Cited**

Application/Control No.

10/068,873

Applicant(s)/Patent Under  
Reexamination  
ZHONG ET AL.

Examiner

Allan R. Wilson

Art Unit

2815

Page 1 of 1

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	A	US-5,914,761	06-1999	Ohe et al.	349/132
	B	US-6,507,045	01-2003	Gu et al.	257/72
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	P					
	Q					
	R					
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Allan R. Wilson

Art Unit

2815

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	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICELIST OF REFERENCES CITED BY  
APPLICANT  
(Use Several Sheets if Necessary)Attorney Docket No.  
8733.216.20Application No.  
TBAApplicant  
John Z. Z. ZHONG et al.Filing Date  
January 10, 2002Group  
TBA

Date: January 10, 2002

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL*	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	4,470,667	9/1984	Okubo et al.			
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## FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION

## OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

	Radler et al. "Bensocyclobutene Dielectric Resins for Flat Panel Display Applications."
	Suzuki. "Invited Address: High-Aperture TFT Array Structures." SID 94 Digest.
	Takeda et al. "A 6.4-in-Diagonal Color TFT-LCD Module Suitable for Personal Information Tools." SID 94 Digest.

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DATE CONSIDERED

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\*\*English-language abstract provided.

U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICELIST OF REFERENCES CITED BY  
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(Use Several Sheets if Necessary)

Date: January 10, 2002

## U.S. PATENT DOCUMENTS

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	5,426,523	6/1995	Shimada et al.			
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	Vignolle et al. "Optimisation of Very Small Pitch Active Matrix LCD for Projection." IEEE, 1991.
	Kim et al. "High-Aperture and Fault-Tolerant Pixel Structure for TFT-LCDs." SID 95 Digest.

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Attorney Docket No.  
8733.216.20Application No.  
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John Z. Z. ZHONG et al.Filing Date  
January 10, 2002Group  
TBA

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EXAMINER INITIAL*	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
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Sakamoto et al. "A High-Aperture Ratio 3-in-Diagonal VGA a-Si Light Valve with Pixel/Data and Pixel/Gate Lines Overlapping." SID 96 Digest.

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**LIST OF REFERENCES CITED BY  
APPLICANT**  
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## **U.S. PATENT DOCUMENTS**

## FOREIGN PATENT DOCUMENTS

**OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)**


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